## MicroMAX Detector Stage

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The MicroMAX beamline at MAX IV Laboratory will employ two detectors to be used independently and move along the beam depending on the diffraction target resolution, starting close to the sample hanging partially over the sample table. The X-ray beam can be deflected by Kirkpatrick-Baez (KB) mirrors in the horizontal and vertical directions or pass undeflected.

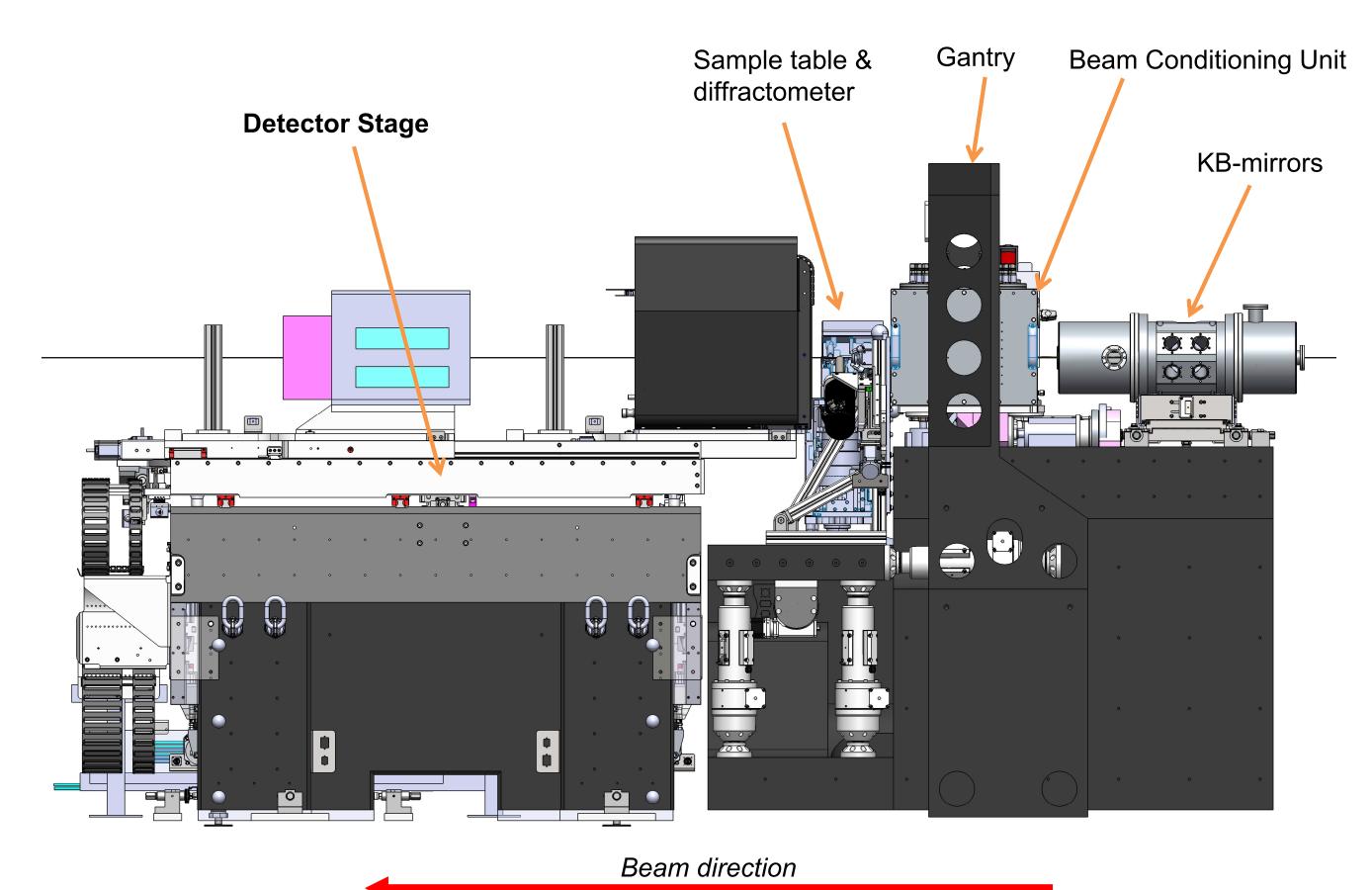
The Max IV Design office designed a detector stage as an in-house project based on the ALBA table skin concept design [1] to switch between the two detectors and accurately position the selected detector, either with or without the KB mirrors.

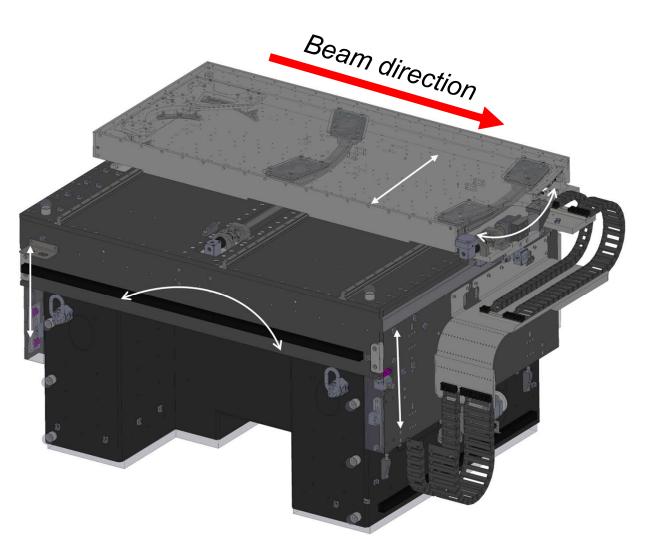
To achieve stability and precision during translations, a large granite block is used, as well as preloaded linear and radial guides, and preloaded ball screws with stepper motors and, in most cases, a gear box. Flexures are used to allow linear motion's pitch and yaw angles.

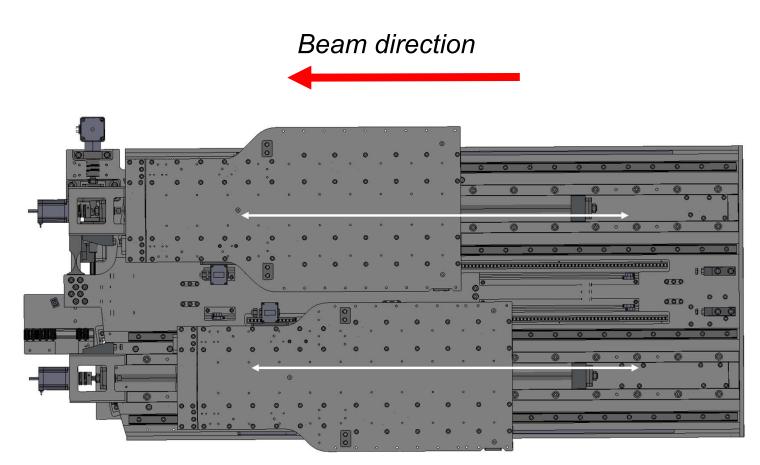
The various motions are layered so that alignment to the beam axis can be do ne first, and then sample-to-detector distance can be adjusted independently. A Finite Element Analysis (FEA) were performed to achieve a stable design and measurements of resonance frequencies on the finalized stage were done to verify it.

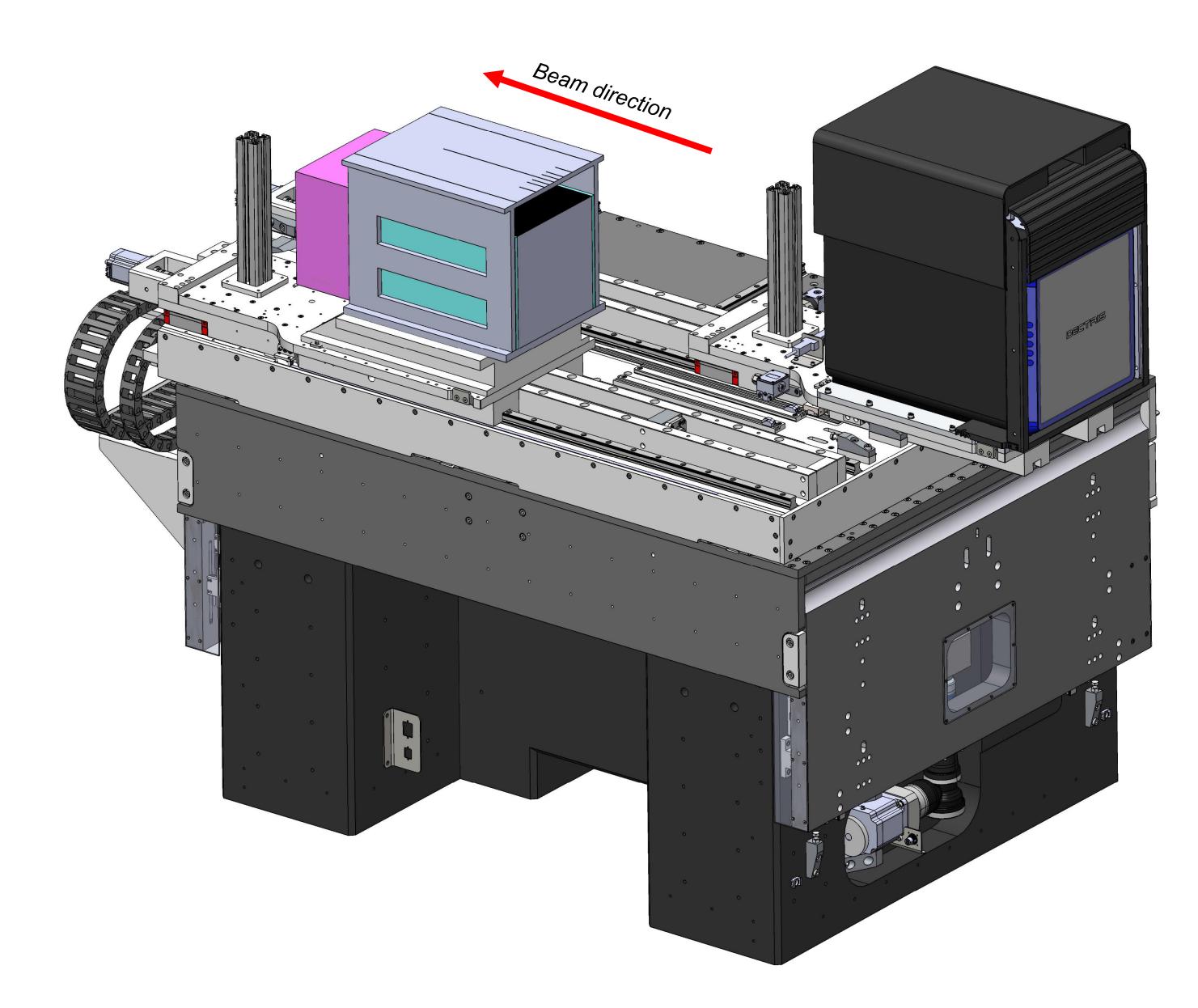
- Switch between two detectors and a position allowing a passthrough vacuum pipe to a second experimental hutch
- Align with the beam, which can be straight or deflected by two Kirkpatrick-Baez (KB) mirrors
- Variable positioning along the beam path, depending on the target resolution of the diffraction data collection.

Specifications						
	Vertical	Horizontal	Longitudinal	Pitch	Yaw	
Range	10 mm	382.5 mm	940 mm	±0.5°	±0.5°	
Resolution	10 μm	10 μm	100 μm	10 μrad	10 μrad	
Repeatability	50 μm	50 μm	100 μm	50 μrad	50 μrad	
Resonance frequency f0	>55 Hz					
RMS displacement	<7.5 μm (<10 % of pixel size)					







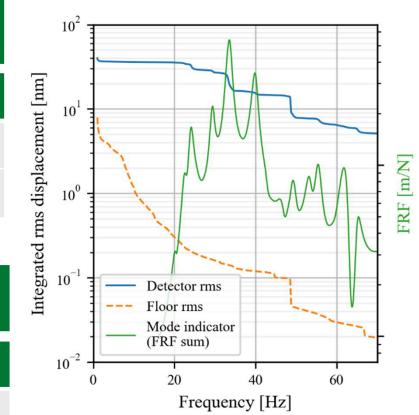


Motion tests <sup>1</sup>						
	Vertical	Horizontal	Longitudinal	Pitch	Yaw	
Resolution	0.1 μm	1 μm	1 μm	<1 µrad	<1 µrad	
Repeatability (closed loop)	<1 μm	<3 μm	<3 μm	<3 μrad	<1 µrad	
Repeatability (open loop)	<5 μm	<7 μm	<7 μm	<5 μrad	<4 μrad	

Modal analysis simulation results				
Case	Mode 1	Mode 2		
Small detector by sample	60.1 Hz	65 Hz		
Detectors centred	63.2 Hz	64.6 Hz		

## Measured RMS Displacements<sup>2</sup>

Direction	Floor	Detector		
Horizontal	3.9 nm	36.8 nm		
Vertical	2.2 nm	60.4 nm		



Integrated RMS ofhorizontal displacement (left y-axis) and mode indicator (right y-axis)

to be related to rigid body rocking of the entire unit on the alignmentfeet and will between detector and floor contribution to the total RMS at 48.6 Hz originating from the floor that will prevail even after grouting.

- <sup>1</sup> Based on comparison between intended translation and encoder measurements
- <sup>2</sup> Measured as currently installed on adjustmentfeet, not grouted





## **Contacts**

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[1] Colldelram C., Rudget C., Nikitina L. October 2011. ALBA XALOC beamline diffractometer table skin concept design. Diamond Light Source Proceedings.



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